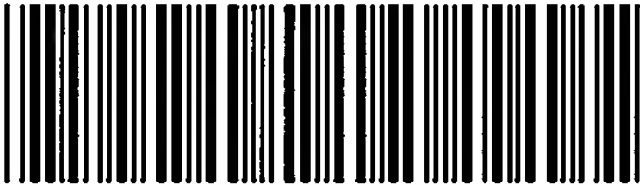


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/606,396	GERMAIN ET AL.	
	Examin r	Art Unit	
	Thien F. Tran	2811	

SEARCHED			
Class	Subclass	Date	Examiner
257	676	1/11/2005	TT
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR